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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Lan Bo Chen et al.
Serial No. : 10/062,197
Filed : February 1, 2002
Title : RARE EVENT DETECTION SYSTEM

Art Unit : 1645
Examiner : Unknown

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Commissioner for Patents
Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449, copies of which are enclosed. A copy of a communication from a foreign patent office in a counterpart application is also enclosed.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: September 10, 2002

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CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, Washington, D.C. 20231.

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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 00530-097001	Application No. 10/062,197
	Applicant Lan Bo Chen et al.		
	Filing Date February 1, 2002	Group Art Unit 1645	



U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	4,271,123	06/02/1981	Curry et al.			
	AB	5,548,661	08/20/1996	Price et al.			
	AC	5,989,835	11/23/1999	Dunlay et al.			
	AD	6,200,762 B1	03/13/2001	Zlokarnik et al.			
	AE	6,221,612 B1	04/24/2001	Knapp et al.			
	AF						
	AG						
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Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
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Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	